






















Search Notes 	Application/Control No. 10530797	Applicant(s)/Patent Under Reexamination BUSCHKE ET AL.
	Examiner Washburn, Douglas N	Art Unit 2863

SEARCHED			
Class	Subclass	Date	Examiner
73	1.82	03/08/2007	DNW 
73	570	03/08/2007	DNW 
73	584	03/08/2007	DNW 
73	598	03/08/2007	DNW 
73	600	03/08/2007	DNW 
702	35	03/08/2007	DNW 
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702	159	03/08/2007	DNW 
702	171	03/08/2007	DNW 

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor name search - see printout - (USPGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM-TDB)	03/08/2007	DNW 
EAST keyword/keyphrase - see printout - (USPGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM-TDB)	03/08/2007	DNW 
IEEE keyword/keyphrase - see printout	03/08/2007	DNW 
G01N29/00 - see printout - (USPGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM-TDB)	03/08/2007	DNW 
G01H17/00 - see printout - (USPGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM-TDB)	03/08/2007	DNW 
G06F11/30 - see printout - (USPGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM-TDB)	03/08/2007	DNW 
G06F15/00 - see printout - (USPGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM-TDB)	03/08/2007	DNW 
G06F19/00 - see printout - (USPGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM-TDB)	03/08/2007	DNW 
73/1.82, 570, 584, 597, 598, 599, 600, 602 - see printout - (USPGPUB; USPAT; USOCR)	03/08/2007	DNW 
702/33, 35, 39, 81, 103, 159, 171, 183 - see printout - (USPGPUB; USPAT; USOCR)	03/08/2007	DNW 

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner